


<b>Search Notes</b>  	<b>Application/Control No.</b>  10814096	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  Lee, Betty	<b>Art Unit</b>  2619

SEARCHED			
Class	Subclass	Date	Examiner
370	464, 465, 470, 471, 472, 473, 474	11/8/2007	BL

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search	11/8/2007	BL
Inventorship Search	5/8/2008	BL
EAST Search	5/8/2008	BL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see Interference Search printout	5/8/2008	BL